

Search Notes



Application/Control No.

10/782,723

Examiner

Kin-Chan Chen

Applicant(s)/Patent under
Reexamination

WANG ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
438	700	1/9/2006	KCC
	706		
	710		
	714		
	715		
	718		
438	719	1/9/06	KCC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East keyword search USPAT, uspg-pub. Epo, Jpo, Derwent ZBM-TDB inventor search	1/9/2006	KCC